

NID9N05ACL, NID9N05BCL

Power MOSFET

9.0 A, 52 V, N-Channel, Logic Level, Clamped MOSFET w/ESD Protection in a DPAK Package



ON Semiconductor®

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Benefits

- High Energy Capability for Inductive Loads
- Low Switching Noise Generation

Features

- Diode Clamp Between Gate and Source
- ESD Protection – HBM 5000 V
- Active Over-Voltage Gate to Drain Clamp
- Scalable to Lower or Higher $R_{DS(on)}$
- Internal Series Gate Resistance
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Automotive and Industrial Markets:
Solenoid Drivers, Lamp Drivers, Small Motor Drivers

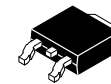
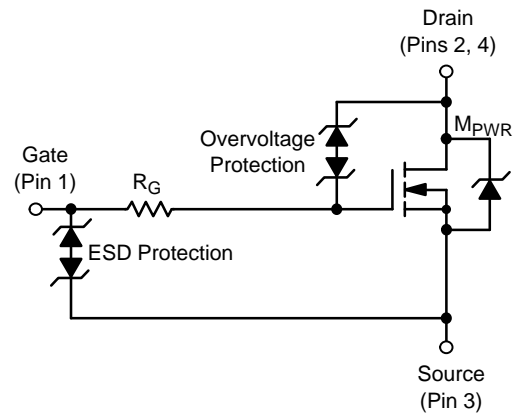
MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage Internally Clamped	V_{DSS}	52–59	V
Gate-to-Source Voltage – Continuous	V_{GS}	± 15	V
Drain Current – Continuous @ $T_A = 25^\circ\text{C}$ – Single Pulse ($t_p = 10 \mu\text{s}$)	I_D I_{DM}	9.0 35	A
Total Power Dissipation @ $T_A = 25^\circ\text{C}$	P_D	1.74	W
Operating and Storage Temperature Range	T_J, T_{stg}	–55 to 175	$^\circ\text{C}$
Single Pulse Drain-to-Source Avalanche Energy – Starting $T_J = 125^\circ\text{C}$ ($V_{DD} = 50 \text{ V}$, $I_{D(pk)} = 1.5 \text{ A}$, $V_{GS} = 10 \text{ V}$, $R_G = 25 \Omega$)	E_{AS}	160	mJ
Thermal Resistance, Junction-to-Case Junction-to-Ambient (Note 1) Junction-to-Ambient (Note 2)	$R_{\theta JC}$ $R_{\theta JA}$ $R_{\theta JA}$	5.2 72 100	$^\circ\text{C/W}$
Maximum Lead Temperature for Soldering Purposes, 1/8" from Case for 10 seconds	T_L	260	$^\circ\text{C}$

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

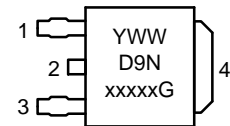
1. When surface mounted to a FR4 board using 1" pad size, (Cu area 1.127 in²).
2. When surface mounted to a FR4 board using minimum recommended pad size, (Cu area 0.412 in²).

V_{DSS} (Clamped)	$R_{DS(on)}$ TYP	I_D MAX (Limited)
52 V	90 m Ω	9.0 A



DPAK
CASE 369C
STYLE 2

MARKING DIAGRAM



Y	= Year	1	= Gate
WW	= Work Week	2	= Drain
xxxxx	= 05ACL or 05BCL	3	= Source
G	= Pb-Free Package	4	= Drain

ORDERING INFORMATION

Device	Package	Shipping†
NID9N05ACL4G	DPAK (Pb-Free)	2500/Tape & Reel
NID9N05BCL4G	DPAK (Pb-Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage (Note 3) (V _{GS} = 0 V, I _D = 1.0 mA, T _J = 25°C) (V _{GS} = 0 V, I _D = 1.0 mA, T _J = -40°C to 125°C) Temperature Coefficient (Negative)	V _{(BR)DSS}	52 50.8 -	55 54 -10	59 59.5 -	V V mV/°C
Zero Gate Voltage Drain Current (V _{DS} = 40 V, V _{GS} = 0 V) (V _{DS} = 40 V, V _{GS} = 0 V, T _J = 125°C)	I _{DSS}	- -	- -	10 25	μA
Gate-Body Leakage Current (V _{GS} = ±8 V, V _{DS} = 0 V) (V _{GS} = ±14 V, V _{DS} = 0 V)	I _{GSS}	- -	- ±22	±10 -	μA

ON CHARACTERISTICS (Note 3)

Gate Threshold Voltage (Note 3) (V _{DS} = V _{GS} , I _D = 100 μA) Threshold Temperature Coefficient (Negative)	V _{GS(th)}	1.3 -	1.75 -4.5	2.5 -	V mV/°C
Static Drain-to-Source On-Resistance (Note 3) (V _{GS} = 4.0 V, I _D = 1.5 A) (V _{GS} = 3.5 V, I _D = 0.6 A) (V _{GS} = 3.0 V, I _D = 0.2 A) (V _{GS} = 12 V, I _D = 9.0 A) (V _{GS} = 12 V, I _D = 12 A)	R _{DS(on)}	- - - 70 67	153 175 - 90 95	181 364 1210 - -	mΩ
Forward Transconductance (Note 3) (V _{DS} = 15 V, I _D = 9.0 A)	g _{FS}	-	24	-	Mhos

DYNAMIC CHARACTERISTICS

Input Capacitance	(V _{DS} = 40 V, V _{GS} = 0 V, f = 10 kHz)	C _{iss}	-	155	250	pF
Output Capacitance		C _{oss}	-	60	100	
Transfer Capacitance		C _{rss}	-	25	40	
Input Capacitance	(V _{DS} = 25 V, V _{GS} = 0 V, f = 10 kHz)	C _{iss}	-	175	-	pF
Output Capacitance		C _{oss}	-	70	-	
Transfer Capacitance		C _{rss}	-	30	-	

SWITCHING CHARACTERISTICS (Note 4)

Turn-On Delay Time	(V _{GS} = 10 V, V _{DD} = 40 V, I _D = 9.0 A, R _G = 9.0 Ω)	t _{d(on)}	-	130	200	ns
Rise Time		t _r	-	500	750	
Turn-Off Delay Time		t _{d(off)}	-	1300	2000	
Fall Time		t _f	-	1150	1850	
Turn-On Delay Time	(V _{GS} = 10 V, V _{DD} = 15 V, I _D = 1.5 A, R _G = 2 kΩ)	t _{d(on)}	-	200	-	ns
Rise Time		t _r	-	500	-	
Turn-Off Delay Time		t _{d(off)}	-	2500	-	
Fall Time		t _f	-	1800	-	
Turn-On Delay Time	(V _{GS} = 10 V, V _{DD} = 15 V, I _D = 1.5 A, R _G = 50 Ω)	t _{d(on)}	-	120	-	ns
Rise Time		t _r	-	275	-	
Turn-Off Delay Time		t _{d(off)}	-	1600	-	
Fall Time		t _f	-	1100	-	
Gate Charge	(V _{GS} = 4.5 V, V _{DS} = 40 V, I _D = 9.0 A) (Note 3)	Q _T	-	4.5	7.0	nC
		Q ₁	-	1.2	-	
		Q ₂	-	2.7	-	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
4. Switching characteristics are independent of operating junction temperatures.

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ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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SWITCHING CHARACTERISTICS (Note 4)

Gate Charge	(V _{GS} = 4.5 V, V _{DS} = 15 V, I _D = 1.5 A) (Note 3)	Q _T	–	3.6	–	nC
		Q ₁	–	1.0	–	
		Q ₂	–	2.0	–	

SOURCE–DRAIN DIODE CHARACTERISTICS

Forward On–Voltage	(I _S = 4.5 A, V _{GS} = 0 V) (Note 3) (I _S = 4.0 A, V _{GS} = 0 V) (I _S = 4.5 A, V _{GS} = 0 V, T _J = 125°C)	V _{SD}	–	0.86	1.2	V
			–	0.845	–	
			–	0.725	–	
Reverse Recovery Time	(I _S = 4.5 A, V _{GS} = 0 V, di _S /dt = 100 A/μs) (Note 3)	t _{rr}	–	700	–	ns
		t _a	–	200	–	
		t _b	–	500	–	
Reverse Recovery Stored Charge		Q _{RR}	–	6.5	–	μC

ESD CHARACTERISTICS

Electro–Static Discharge Capability	Human Body Model (HBM)	ESD	5000	–	–	V
	Machine Model (MM)		500	–	–	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
4. Switching characteristics are independent of operating junction temperatures.

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TYPICAL PERFORMANCE CURVES

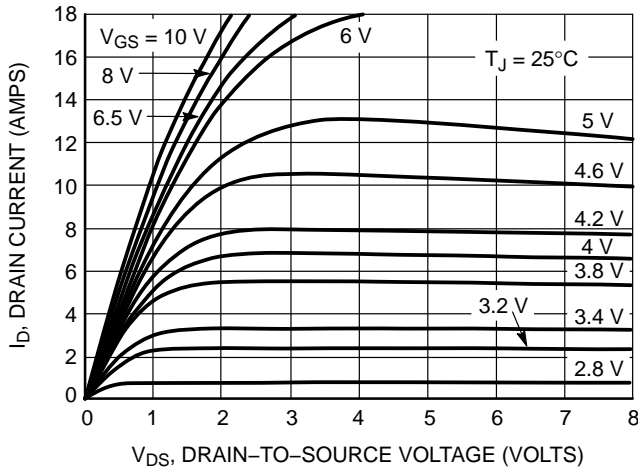


Figure 1. On-Region Characteristics

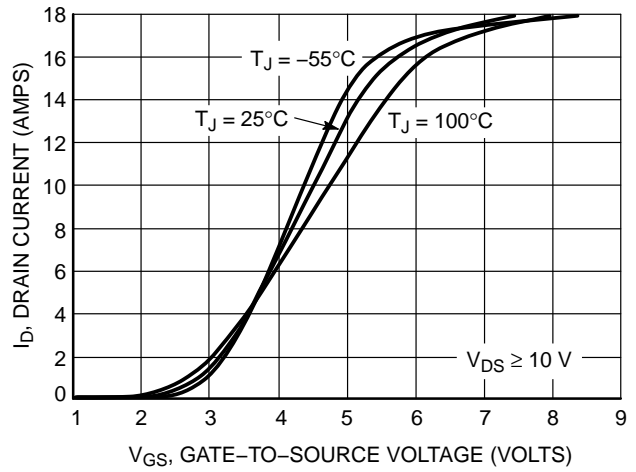


Figure 2. Transfer Characteristics

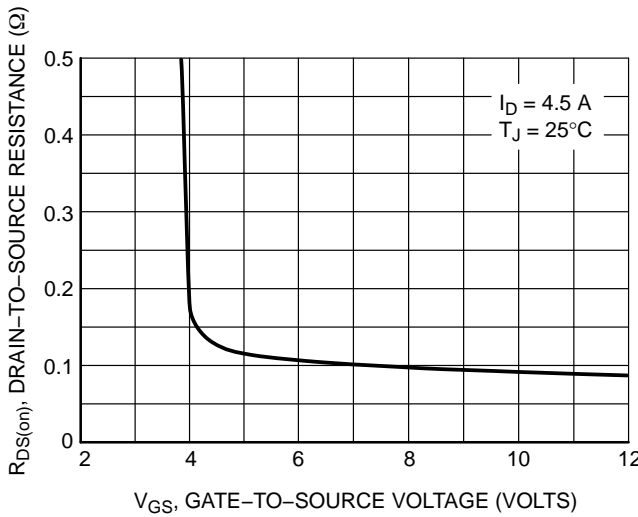


Figure 3. On-Resistance versus Gate-to-Source Voltage

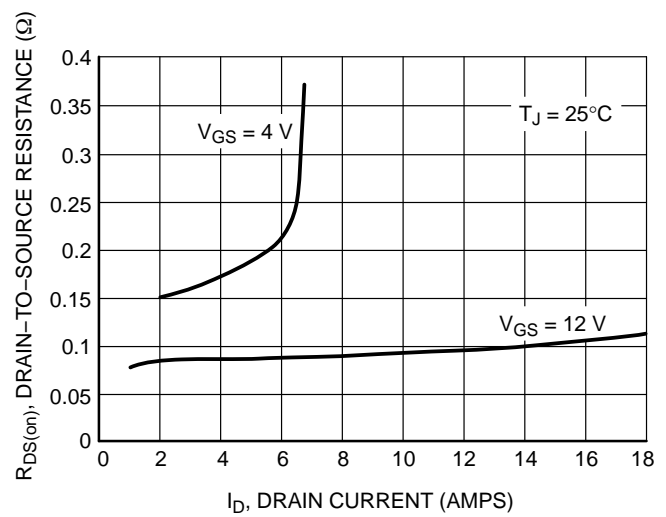


Figure 4. On-Resistance versus Drain Current and Gate Voltage

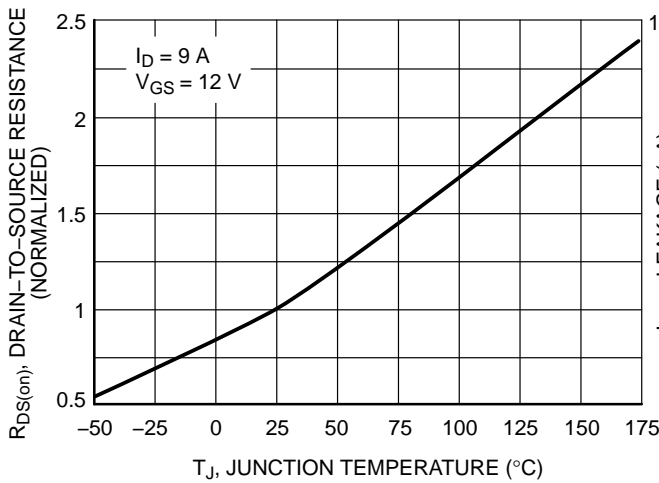


Figure 5. On-Resistance Variation with Temperature

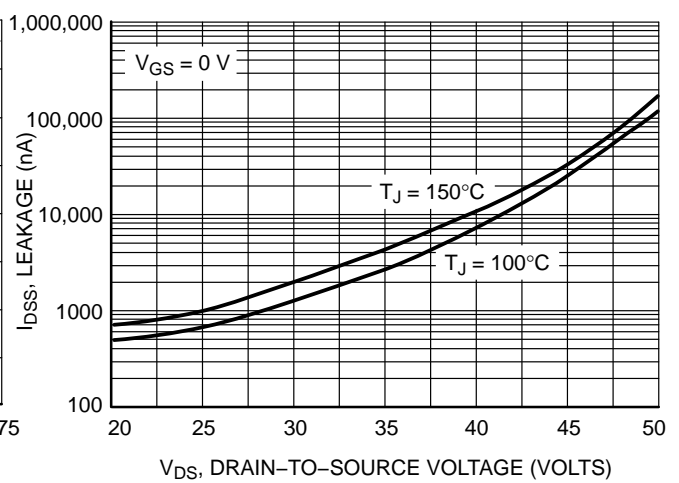


Figure 6. Drain-to-Source Leakage Current versus Voltage

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TYPICAL PERFORMANCE CURVES

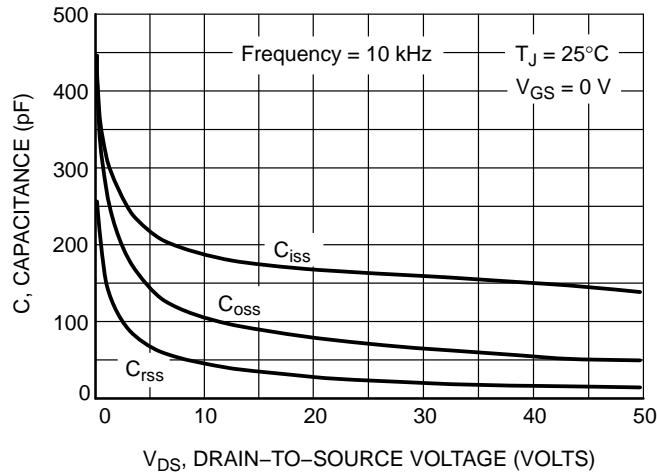


Figure 7. Capacitance Variation

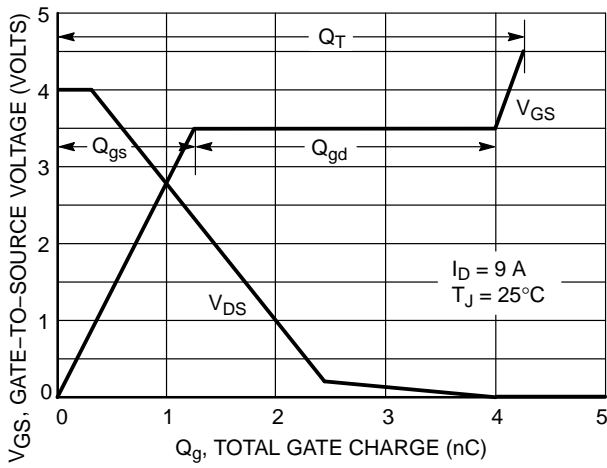


Figure 8. Gate-To-Source and Drain-To-Source Voltage versus Total Charge

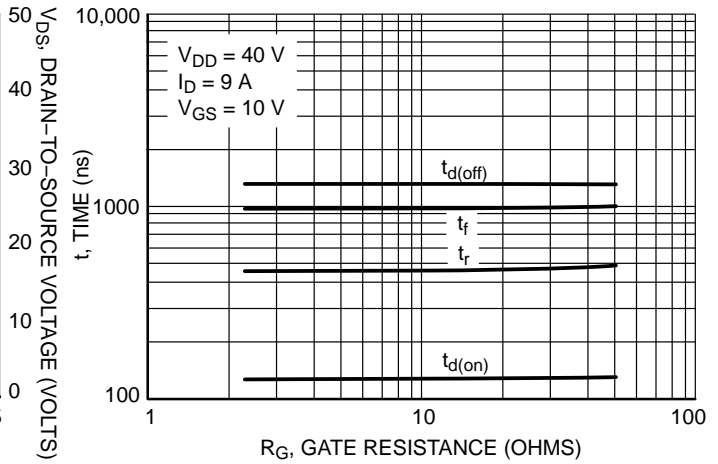


Figure 9. Resistive Switching Time Variation versus Gate Resistance

DRAIN-TO-SOURCE DIODE CHARACTERISTICS

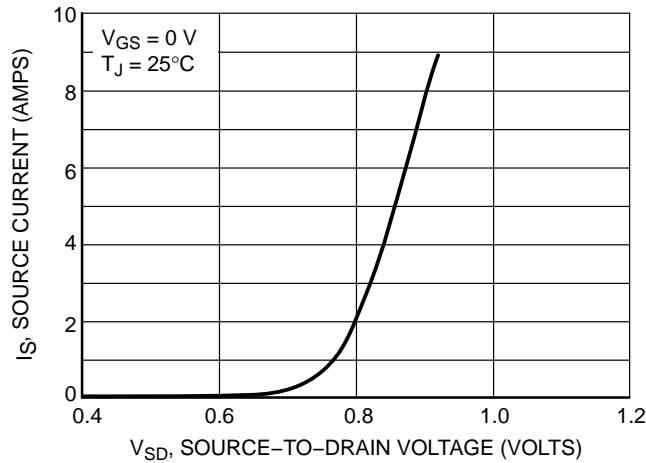


Figure 10. Diode Forward Voltage versus Current

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SAFE OPERATING AREA

The Forward Biased Safe Operating Area curves define the maximum simultaneous drain-to-source voltage and drain current that a transistor can handle safely when it is forward biased. Curves are based upon maximum peak junction temperature and a case temperature (T_C) of 25°C. Peak repetitive pulsed power limits are determined by using the thermal response data in conjunction with the procedures discussed in AN569, "Transient Thermal Resistance – General Data and Its Use."

Switching between the off-state and the on-state may traverse any load line provided neither rated peak current (I_{DM}) nor rated voltage (V_{DSS}) is exceeded and the transition time (t_r, t_f) do not exceed 10 μ s. In addition the total power averaged over a complete switching cycle must not exceed $(T_{J(MAX)} - T_C)/(R_{\theta JC})$.

A Power MOSFET designated E-FET can be safely used in switching circuits with unclamped inductive loads. For

reliable operation, the stored energy from circuit inductance dissipated in the transistor while in avalanche must be less than the rated limit and adjusted for operating conditions differing from those specified. Although industry practice is to rate in terms of energy, avalanche energy capability is not a constant. The energy rating decreases non-linearly with an increase of peak current in avalanche and peak junction temperature.

Although many E-FETs can withstand the stress of drain-to-source avalanche at currents up to rated pulsed current (I_{DM}), the energy rating is specified at rated continuous current (I_D), in accordance with industry custom. The energy rating must be derated for temperature as shown in the accompanying graph (Figure 12). Maximum energy at currents below rated continuous I_D can safely be assumed to equal the values indicated.

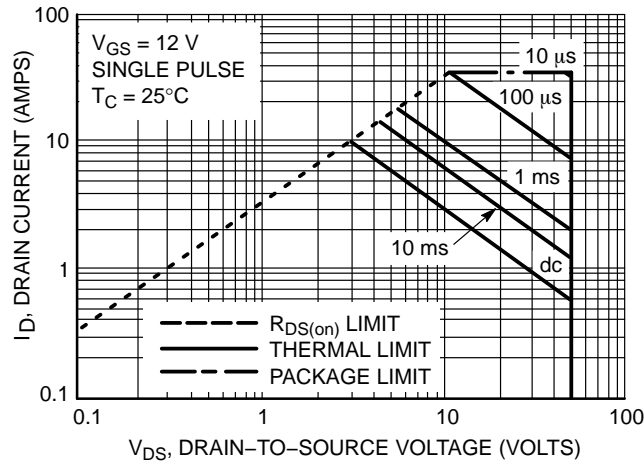


Figure 11. Maximum Rated Forward Biased Safe Operating Area

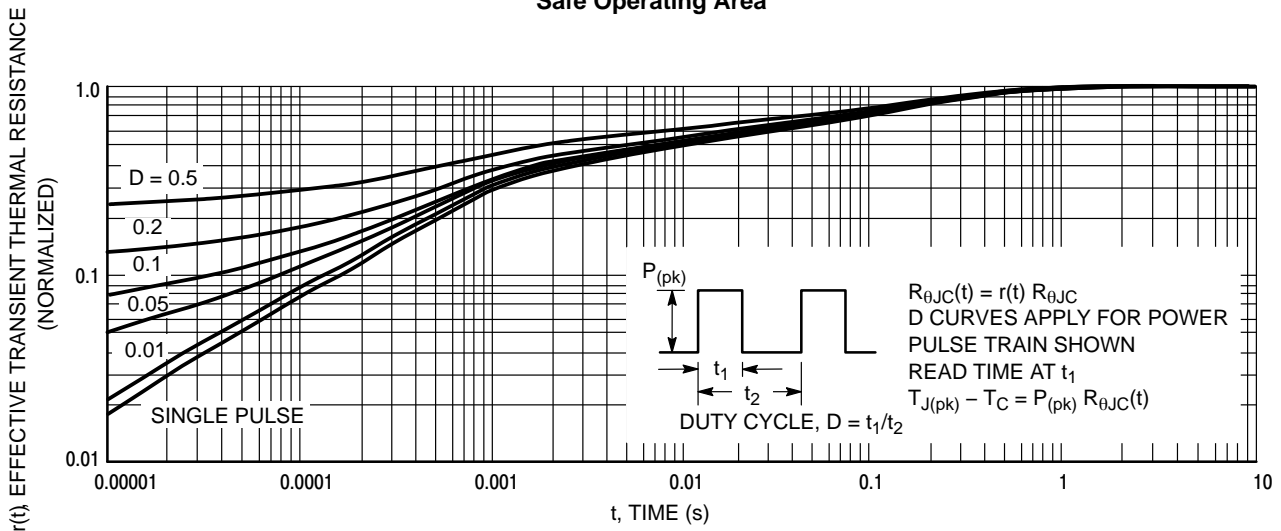
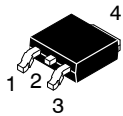


Figure 12. Thermal Response

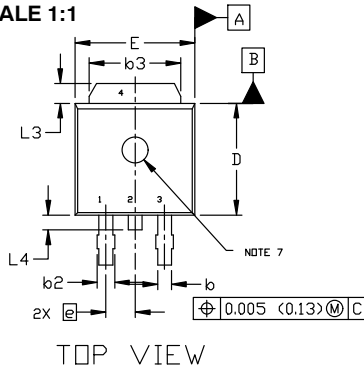
MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS



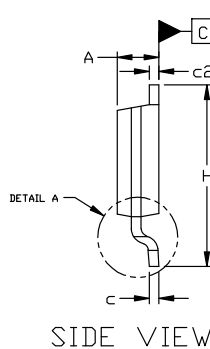
DPAK (SINGLE GAUGE) CASE 369C ISSUE G

DATE 31 MAY 2023

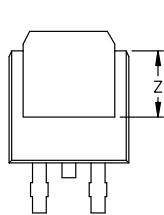
SCALE 1:1



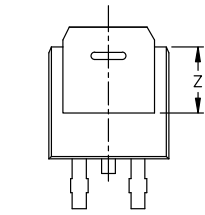
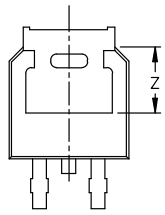
TOP VIEW



SIDE VIEW

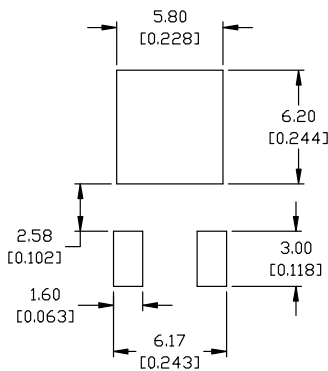


BOTTOM VIEW



BOTTOM VIEW

ALTERNATE CONSTRUCTIONS



RECOMMENDED MOUNTING FOOTPRINT*

*FOR ADDITIONAL INFORMATION ON OUR Pb-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERM/D.

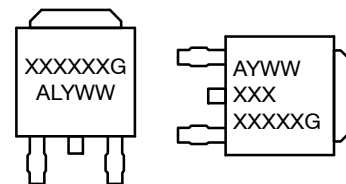
- | | | | | |
|--|--|---|---|--|
| <p>STYLE 1:
PIN 1. BASE
2. COLLECTOR
3. EMITTER
4. COLLECTOR</p> | <p>STYLE 2:
PIN 1. GATE
2. DRAIN
3. SOURCE
4. DRAIN</p> | <p>STYLE 3:
PIN 1. ANODE
2. CATHODE
3. ANODE
4. CATHODE</p> | <p>STYLE 4:
PIN 1. CATHODE
2. ANODE
3. GATE
4. ANODE</p> | <p>STYLE 5:
PIN 1. GATE
2. ANODE
3. CATHODE
4. ANODE</p> |
| <p>STYLE 6:
PIN 1. MT1
2. MT2
3. GATE
4. MT2</p> | <p>STYLE 7:
PIN 1. GATE
2. COLLECTOR
3. EMITTER
4. COLLECTOR</p> | <p>STYLE 8:
PIN 1. N/C
2. CATHODE
3. ANODE
4. CATHODE</p> | <p>STYLE 9:
PIN 1. ANODE
2. CATHODE
3. RESISTOR ADJUST
4. CATHODE</p> | <p>STYLE 10:
PIN 1. CATHODE
2. ANODE
3. CATHODE
4. ANODE</p> |

NOTES:

- DIMENSIONING AND TOLERANCING ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: INCHES
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3, AND Z.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- OPTIONAL MOLD FEATURE.

DIM	INCHES		MILLIMETERS	
	MIN.	MAX.	MIN.	MAX.
A	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.028	0.045	0.72	1.14
b3	0.180	0.215	4.57	5.46
c	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
e	0.090	BSC	2.29	BSC
H	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.114	REF	2.90	REF
L2	0.020	BSC	0.51	BSC
L3	0.035	0.050	0.89	1.27
L4	----	0.040	---	1.01
Z	0.155	----	3.93	---

GENERIC MARKING DIAGRAM*



IC

Discrete

- XXXXXX = Device Code
- A = Assembly Location
- L = Wafer Lot
- Y = Year
- WW = Work Week
- G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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